

150 W – 50 V moisture resistant HF/VHF DMOS transistor

Datasheet - production data

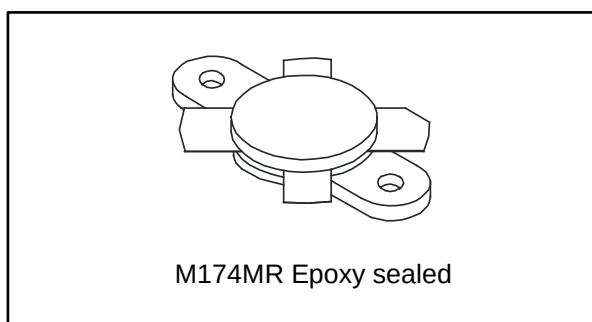
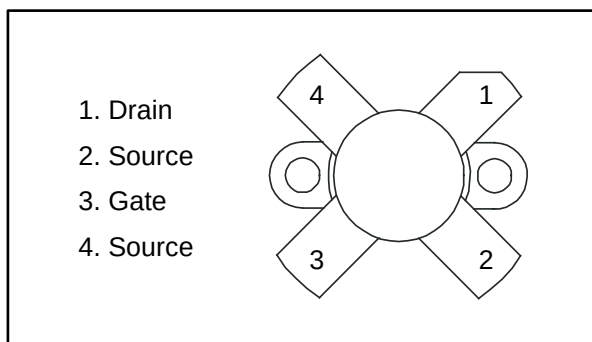


Figure 1: Pin connection



Description

The SD2931-12MR is a gold metallized N-channel MOS field-effect RF power transistor. Electrically identical to the standard SD2931 MOSFET, it is intended for use in 50 V DC large signal applications up to 230 MHz.

The SD2931-12MR is mechanically compatible with the SD2931 but offers better thermal capability (25% lower thermal resistance), representing the best-in-class in transistors for ISM applications, where reliability and ruggedness are critical factors.

The SD2931-12MR benefits from the latest generation of environmentally designed packaging, ruggedized against cyclic high moisture operation and severe storage conditions.

Table 1: Device summary

Order code	Marking	Package	Packaging
SD2931-12MR	SD2931-12MR ⁽¹⁾	M174MR	Plastic tray

Notes:

⁽¹⁾ For more details please refer to "Marking, packing and shipping specifications".

Features

- Gold metallization
- Excellent thermal stability
- Common source, push-pull configuration
- $P_{OUT} = 150$ W min. with 14 dB gain @ 175 MHz
- Thermally enhanced packaging for lower junction temperatures
- G_{FS} and V_{GS} sort marked on unit
- Moisture resistant package specifically designed to operate in extreme environments

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1 Electrical data

1.1 Maximum rating

$T_{CASE} = 25\text{ °C}$

Table 2: Absolute maximum rating

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}$	Drain source voltage	125	V
V_{DGR}	Drain-gate voltage ($R_{GS} = 1\text{MW}$)	125	V
V_{GS}	Gate-source voltage	± 20	V
I_D	Drain current	20	A
P_{DISS}	Power dissipation	389	W
T_J	Max. operating junction temperature	200	°C
T_{STG}	Storage temperature	-65 to +150	°C

1.2 Thermal data

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Junction to case thermal resistance	0.45	°C/W

2 Electrical characteristics

$T_{CASE} = 25\text{ }^{\circ}\text{C}$

Table 4: Static

Symbol	Test conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$	$I_{DS} = 100\text{ mA}$	125			V
I_{DSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 5\text{ V}$			20	μA
	$V_{GS} = 0\text{ V}$	$V_{DS} = 50\text{ V}$			50	
I_{GSS}	$V_{GS} = 20\text{ V}$	$V_{DS} = 0\text{ V}$			250	nA
$V_{GS(Q)}^{(1)}$	$V_{DS} = 10\text{ V}$	$I_D = 250\text{ mA}$	see table below			V
$V_{DS(ON)}$	$V_{GS} = 10\text{ V}$	$I_D = 10\text{ A}$			3.0	V
$G_{FS}^{(1)}$	$V_{DS} = 10\text{ V}$	$I_D = 5\text{ A}$	see table below			mho
C_{ISS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 50\text{ V}$	$f = 1\text{ MHz}$	480		pF
C_{OSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 50\text{ V}$	$f = 1\text{ MHz}$	190		pF
C_{RSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 50\text{ V}$	$f = 1\text{ MHz}$	18		pF

Notes:

⁽¹⁾ $V_{GS(Q)}$ and G_{FS} sorted with alpha/numeric code marked on unit.

Table 5: V_{GS} and G_{FS} sorts

	V_{GS}	G_{FS}
I	2.65 - 3.15	6.0 - 6.5
J	2.65 - 3.15	6.5 - 7.0
K	2.65 - 3.15	7.0 - 7.5

Table 6: Dynamic

Symbol	Test conditions	Min.	Typ.	Max.	Unit
P_{OUT}	$V_{DD} = 50\text{ V}$ $I_{DQ} = 250\text{ mA}$ $f = 175\text{ MHz}$	150			W
G_{PS}	$V_{DD} = 50\text{ V}$ $I_{DQ} = 250\text{ mA}$ $P_{OUT} = 150\text{ W}$ $f = 175\text{ MHz}$	14	15		dB
η_D	$V_{DD} = 50\text{ V}$ $I_{DQ} = 250\text{ mA}$ $P_{OUT} = 150\text{ W}$ $f = 175\text{ MHz}$	55	65		%
Load mismatch	$V_{DD} = 50\text{ V}$ $I_{DQ} = 250\text{ mA}$ $P_{OUT} = 150\text{ W}$ $f = 175\text{ MHz}$ all phase angles	10:1			VSWR

3 Impedance

Figure 2: Impedance data schematic

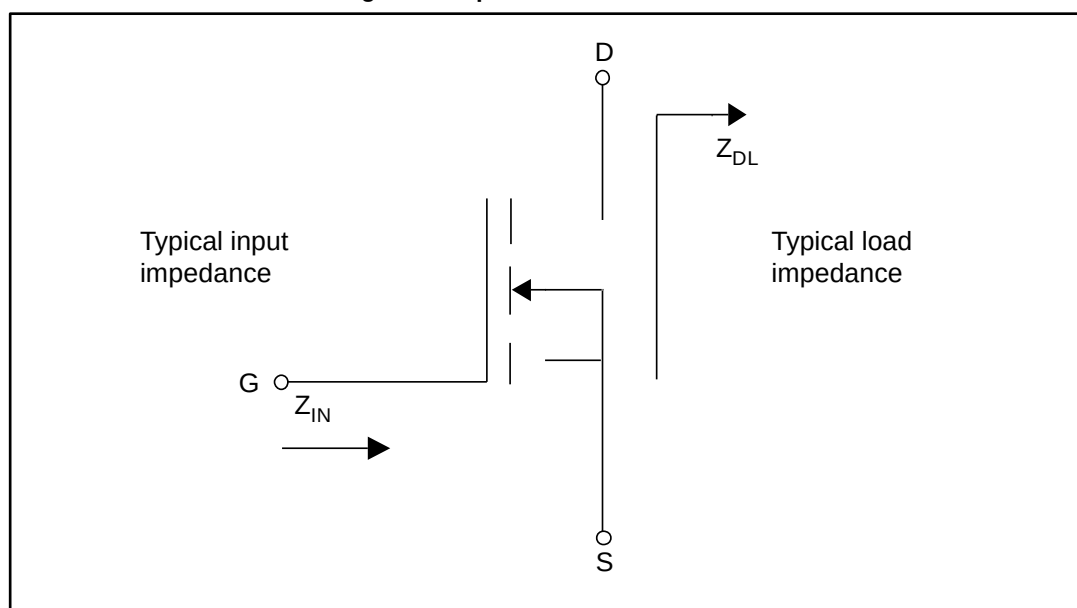


Table 7: Impedance data

f	Z IN(Ω)	Z DL(Ω)
30 MHz	1.7 - j 5.7	6.8 + j 0.9
175 MHz	1.2 - j 2.0	2.0 + j 2.4

4 Transient thermal impedance

Figure 3: Transient thermal impedance

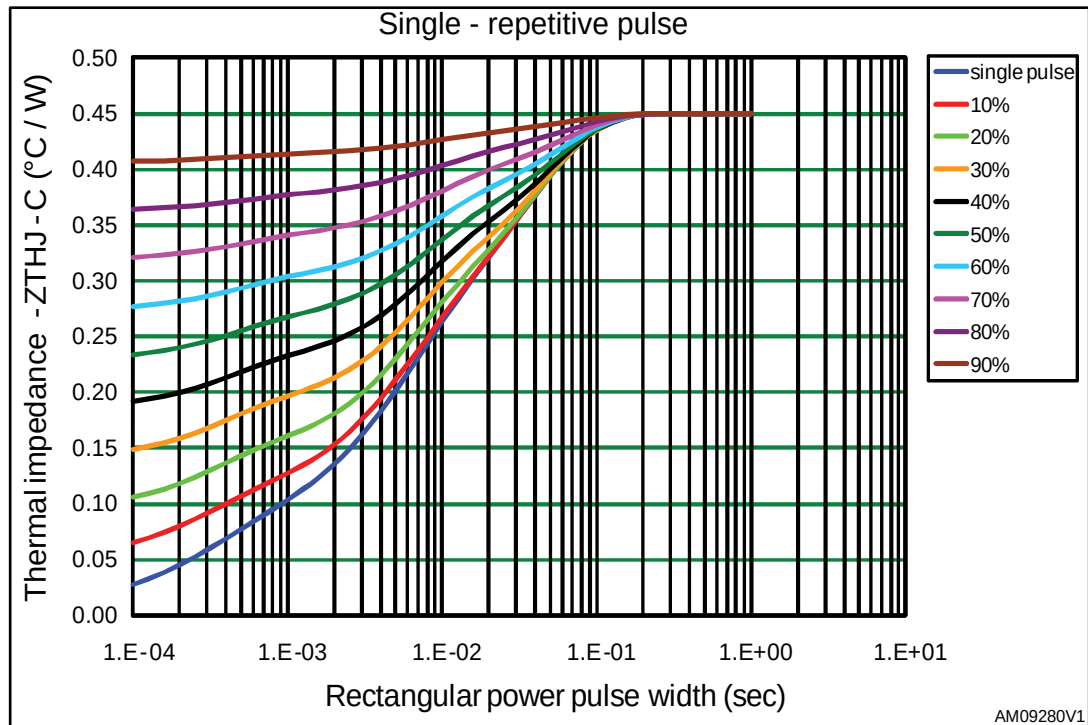
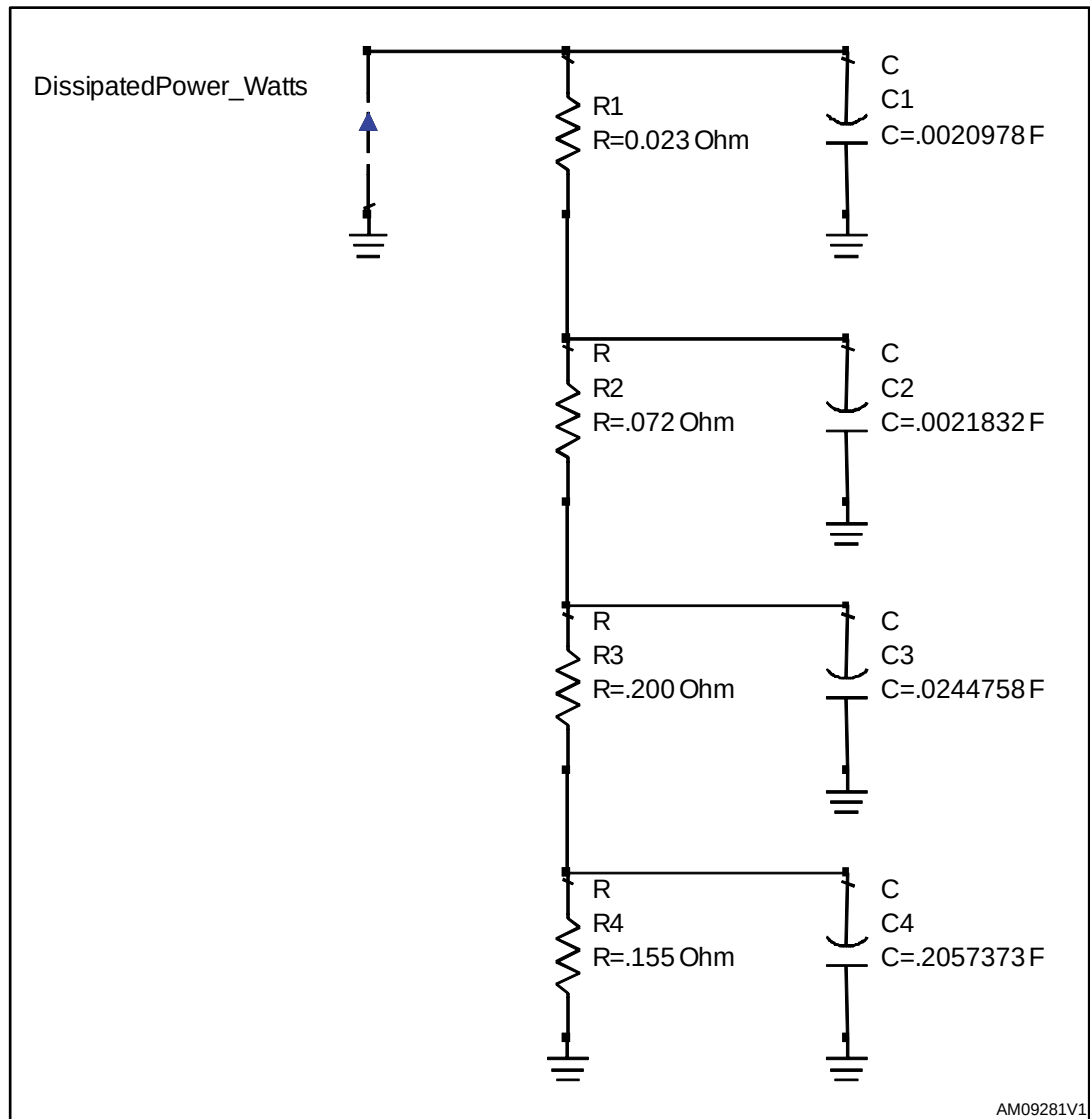


Figure 4: Transient thermal impedance model



5 Typical performance

Figure 5: Capacitance vs. drain voltage

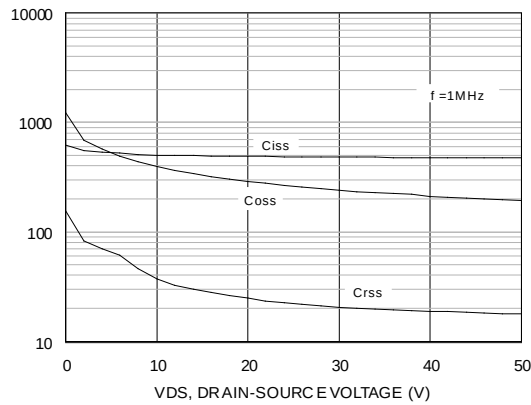


Figure 6: Drain current vs. gate voltage

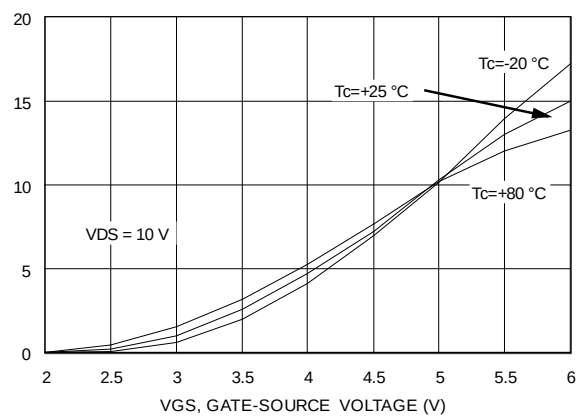


Figure 7: Gate-source voltage vs. case temperature

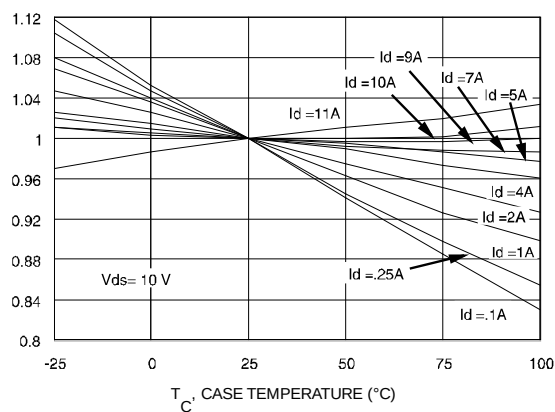


Figure 8: Maximum thermal resistance vs. case temperature

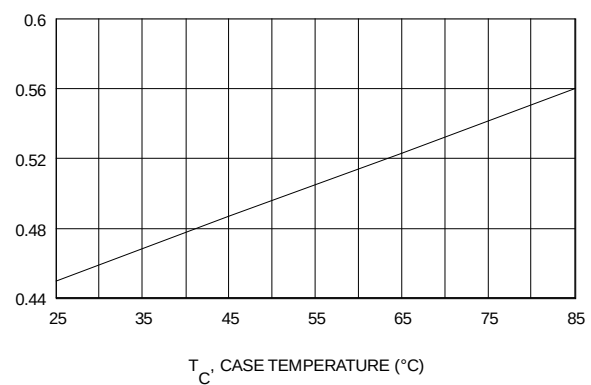
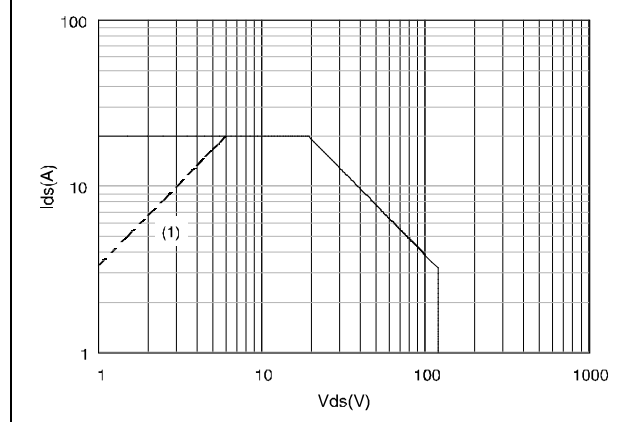


Figure 9: Safe operating area



5.1 Typical performance (175 MHz)

Figure 10: Output power vs. input power

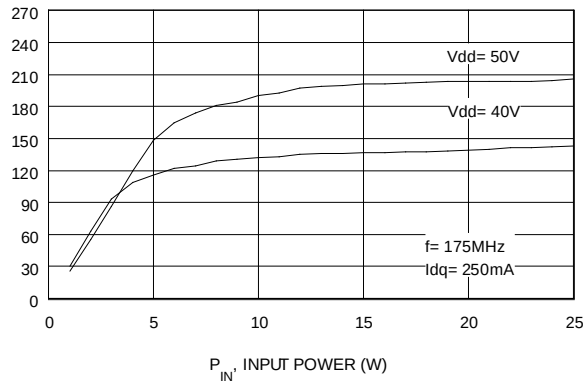


Figure 11: Output power vs. input power at different Tc

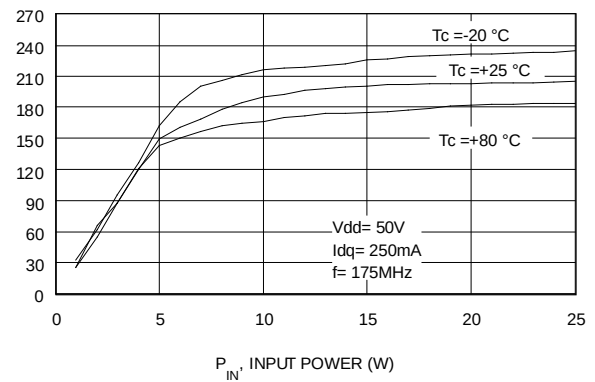


Figure 12: Power gain vs. output power

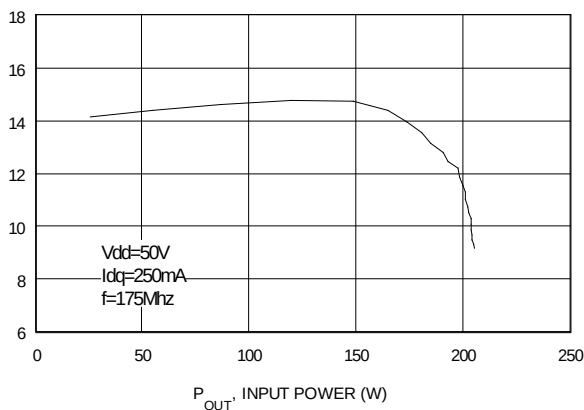


Figure 13: Efficiency vs. output power

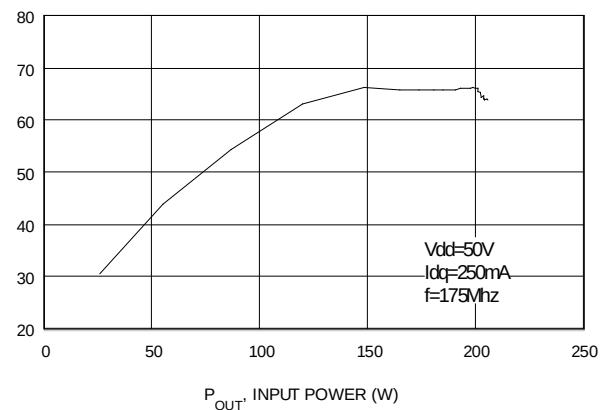


Figure 14: Output power vs. supply voltage

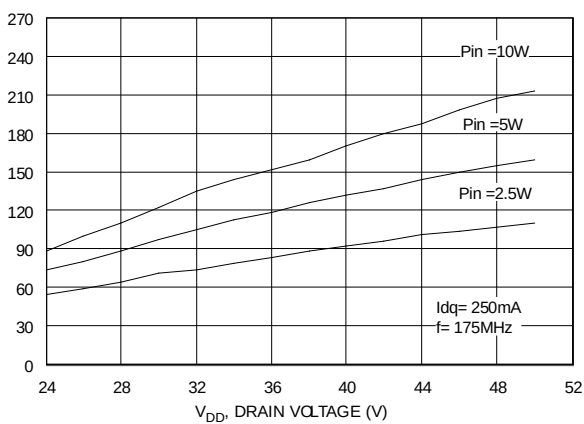
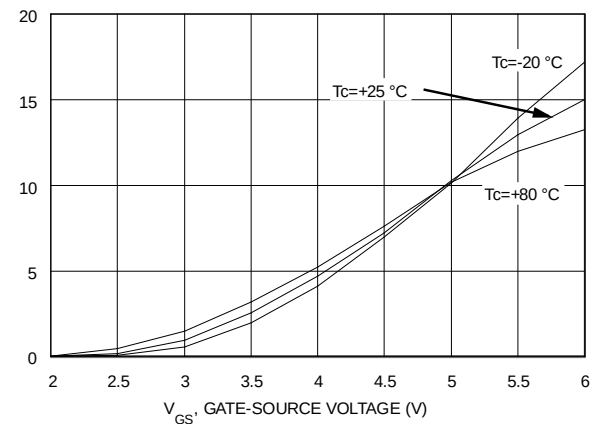


Figure 15: Drain current vs. gate-source voltage



5.1.1 Test circuit (175 MHz)

Figure 16: 175 MHz test circuit schematic (production test circuit)

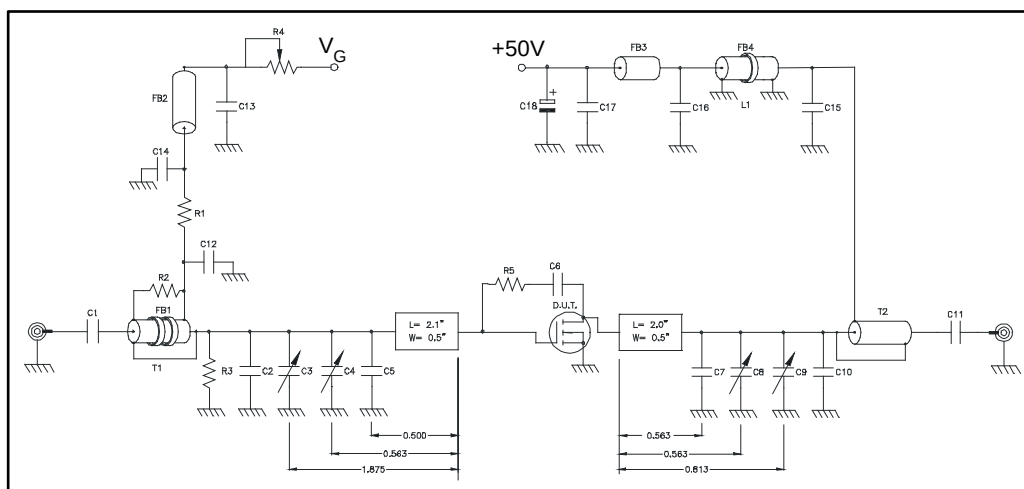


Table 8: 175 MHz test circuit parts list

Component	Description
T1	4:1 transformer, 25 Ω flexible coax .090 OD 6" long
T2	1:4 transformer, 25 Ω semi-rigid coax .141 OD 6" long
FB1	Toroid X 2, 0.5" OD .312" ID 850 μ 2 turns
FB2, FB3	VK200
FB4	Shield bead, 1" OD 0.5" ID 850 μ 3 turns
L1	1/4 wave choke, 50 Ω semi-rigid coax .141 OD 12" Long
PCB	0.62" woven fiberglass, 1 oz. copper, 2 Sides, $\epsilon_r = 2.55$
R1, R3	470 Ω 1 W chip resistor
R2	360 Ω 1/2 W resistor
R4	20 k Ω 10 turn potentiometer
R5	560 Ω 1 W resistor
C1, C11	470 pF ATC chip cap
C2	43 pF ATC chip cap
C3, C8, C9	Arco 404, 12-65 pF
C4	Arco 423, 16-100 pF
C5	120 pF ATC chip cap
C6	0.01 μ F ATC chip cap
C7	30 pF ATC chip cap
C10	91 pF ATC chip cap
C12, C15	1200 pF ATC chip cap
C13, C14, C16, C17	0.01 μ F / 500 V chip cap
C18	10 μ F 63 V electrolytic capacitor

Figure 17: 175 MHz test circuit photomaster

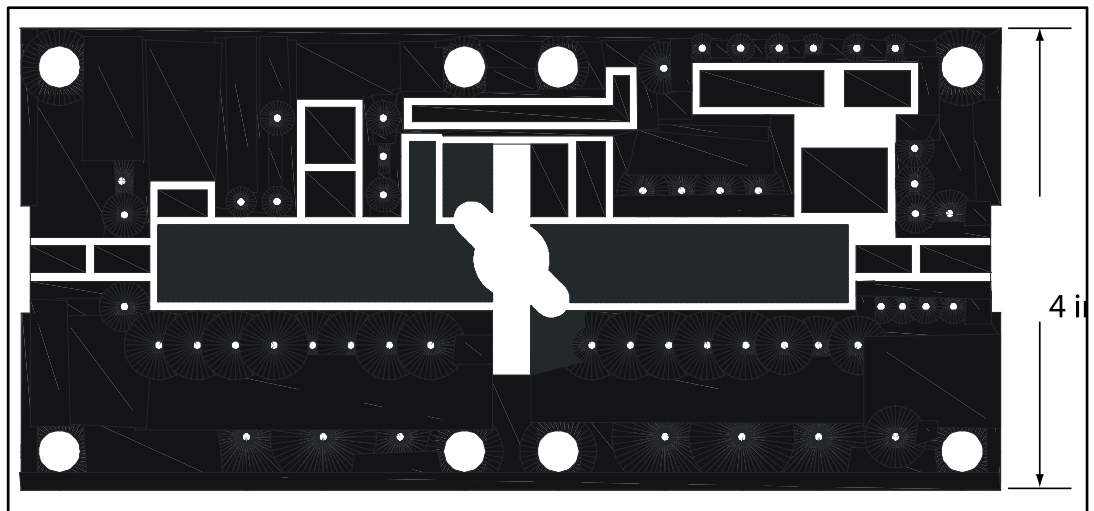
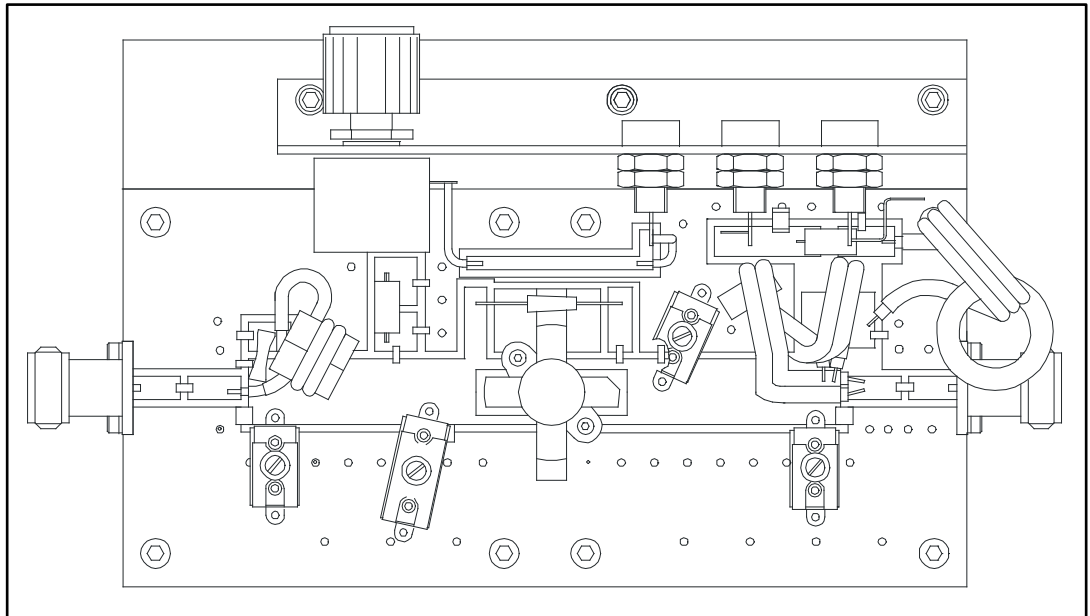


Figure 18: 175 MHz test circuit



5.3 Typical performance (30 MHz)

Figure 19: Output power vs. input power

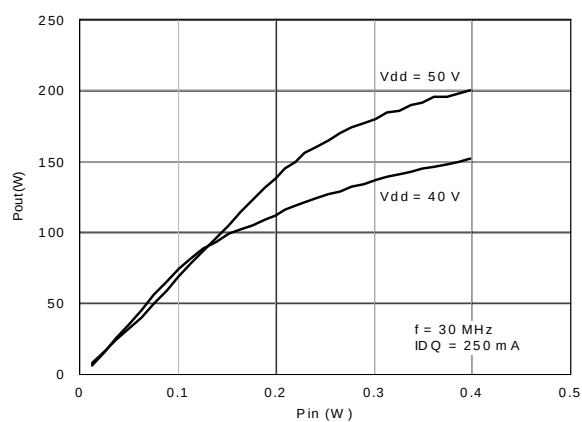


Figure 20: Power gain vs. output power

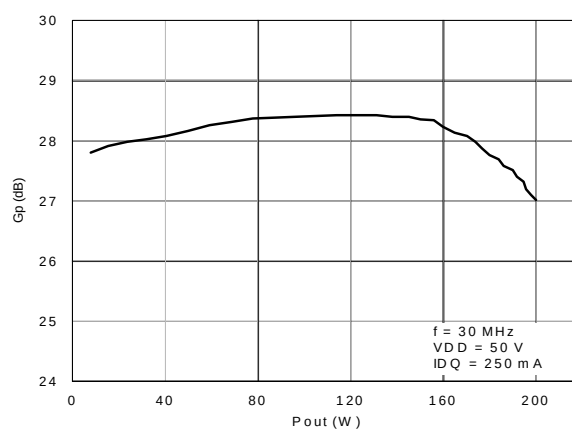


Figure 21: Efficiency vs. output power

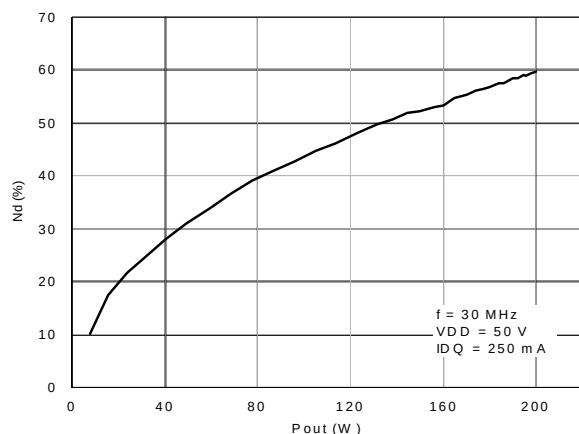


Figure 22: Output power vs. supply voltage

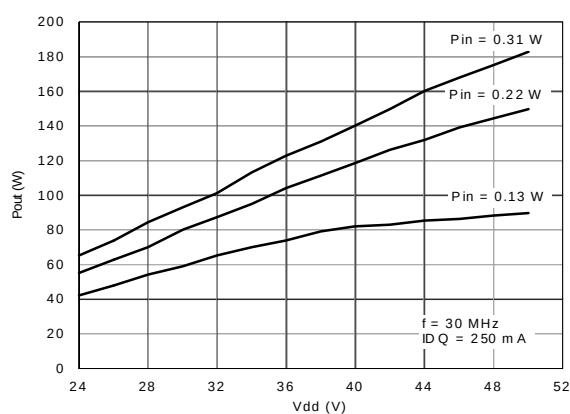
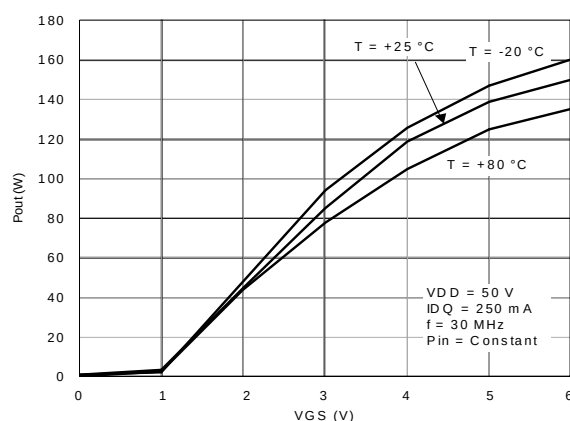


Figure 23: Output power vs. gate-source voltage



5.3.1 Test circuit (30 MHz)

Figure 24: 30 MHz test circuit schematic (production test circuit)

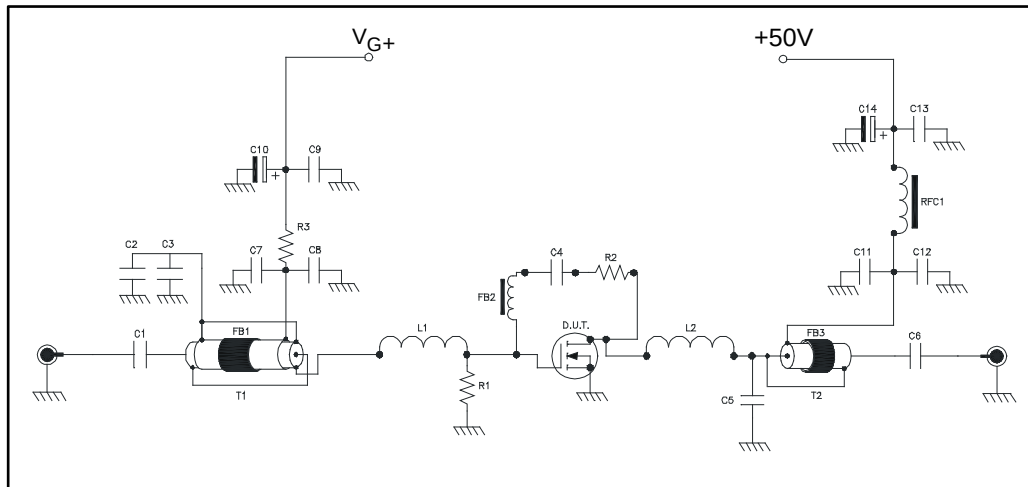


Table 9: 30 MHz test circuit part list

Component	Description
T1	9:1 transformer, 25 Ω flexible coax with extra shield .090 OD 15" long
T2	1:4 transformer, 50 Ω flexible coax .225 OD 15" long
FB1	Toroid 1.7" OD .30" ID 220 μ 4 turns
FB2	Surface mount EMI shield bead
FB3	Toroid 1.7" OD .300" ID 220 μ 3 turns
RFC1	Toroid 0.5" OD 0.30" ID 125 μ 4 turns 12 awg wire
PCB	0.62" woven fiberglass, 1 oz. copper, 2 Sides, $\epsilon_r = 2.55$
R1, R3	1 kohm 1 W chip resistor
R2	680 ohm 3 W wirewound resistor
C1,C4,C6,C7,C8,C9, C11,C12,C13	0.1 μ F ATC chip cap
C2,C3	750 pF ATC chip cap
C5	470 pF ATC chip cap
C10	10 μ F 63 V electrolytic capacitor
C14	100 μ F 63 V electrolytic capacitor

6 Marking, packing and shipping specifications

Table 10: Packing and shipping specifications

Order code	Packaging	Pcs per tray	Dry pack humidity	V _{GS} and G _{FS} code	Lot code
SD2931-12MR	Plastic tray	25	< 10%	Not mixed	Not mixed

Figure 25: Marking layout for SD2931-12MR

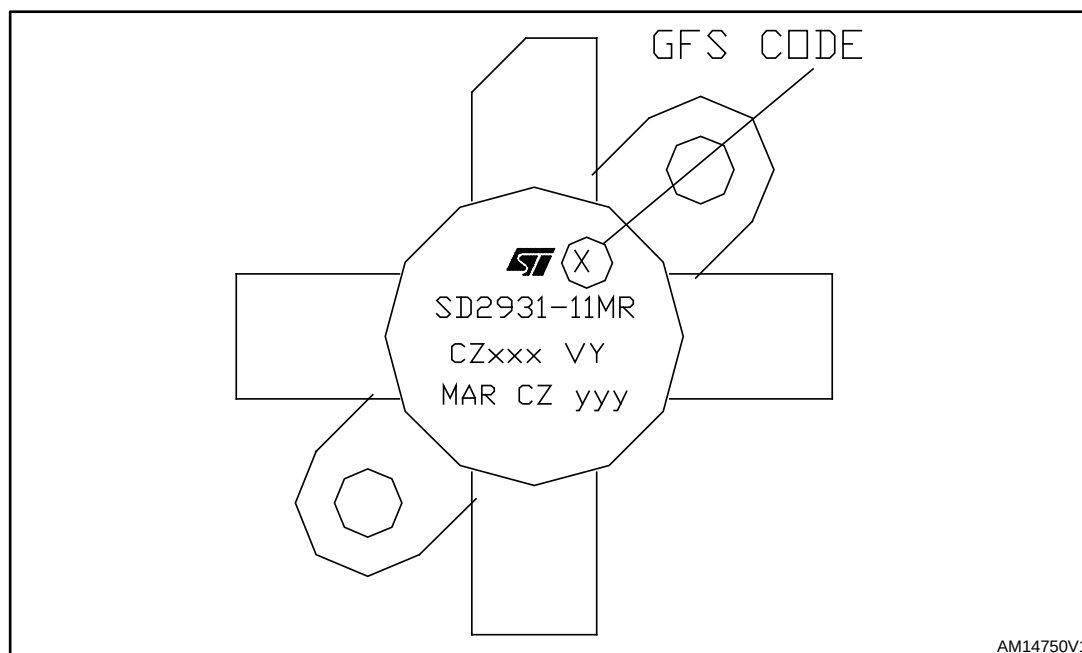


Table 11: Marking specifications

Symbol	Description
X	V _{GS} and G _{FS} sort
CZ	Assembly plant
xxx	Last 3 digits of diffusion lot
VY	Diffusion plant
MAR	Country of origin
CZ	Test and finishing plant
y	Assembly year
yy	Assembly week

7 Package information

7.1 M174MR package information

Figure 26: M174MR drawing

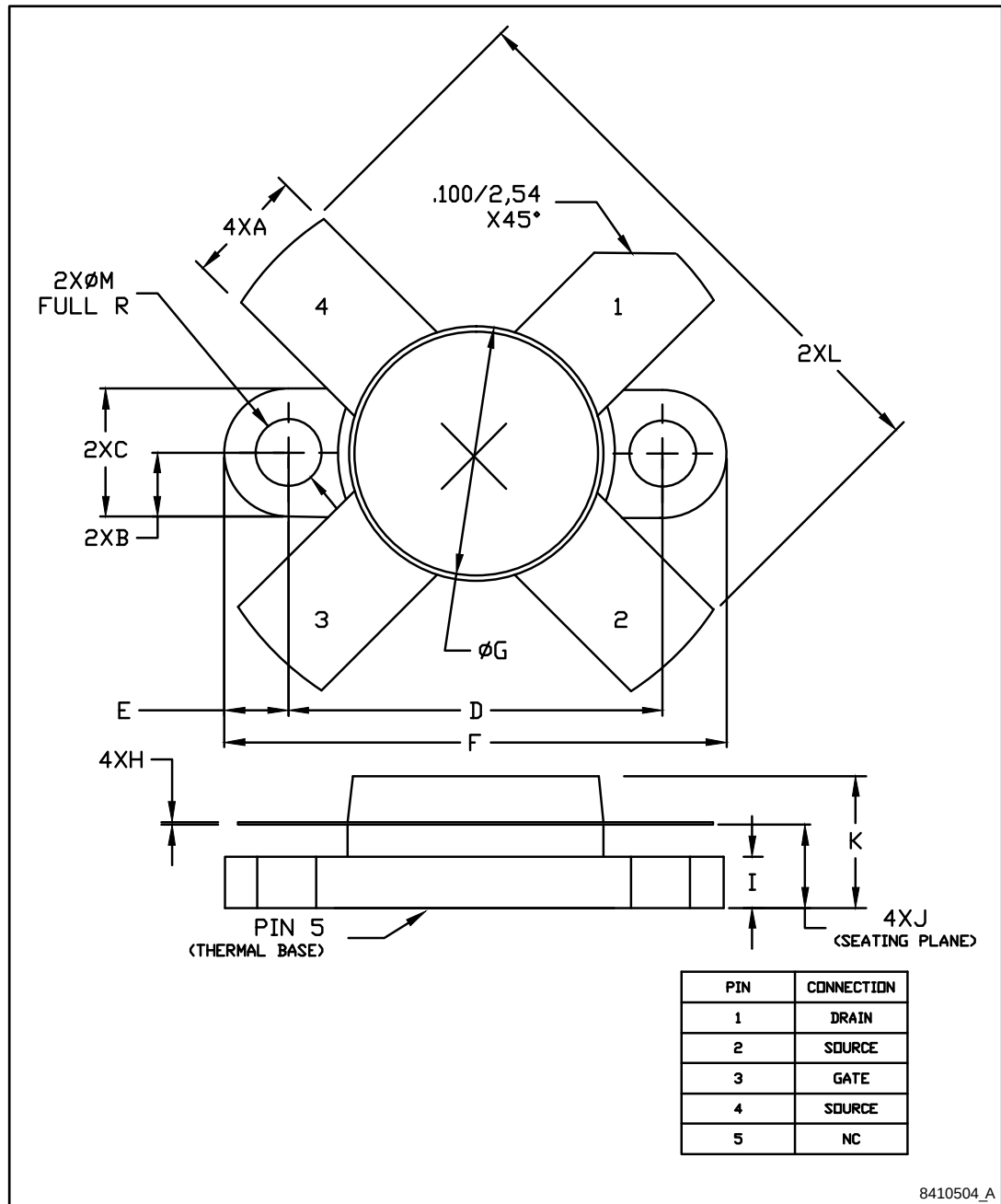


Table 12: M174MR mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	5.56		5.84
B		3.18	
C	6.22		6.48
D	18.29		18.54
E		3.18	
F	24.64		24.89
G	12.07		12.83
H	0.08		0.18
I	2.11		3.00
J	3.81		4.45
K			8.00
L	25.53		26.67
M	3.05		3.30

8 Revision history

Table 13: Document revision history

Date	Revision	Changes
20-Feb-2013	1	First issue.
10-Sep-2013	2	– Document promoted from preliminary data to full datasheet. – Formatting and minor text changes.

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